

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NARUTAKI ET AL.	
		Examiner Kenneth A Parker	Art Unit 2871	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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	N	JP 11052366 A	02-1999	Japan	FUKUYOSHI et al.	G02F 01/1335
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NON-PATENT DOCUMENTS

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